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Optics and optical instruments — Test methods for telescopic systems —

Part 8: Test methods for night-vision devices

Optique et instruments d'optique — Méthodes d'essai pour systèmes télescopiques —

Partie 8: Méthodes d'essai pour dispositifs de vision de nuit



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Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

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Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. ISO shall not be held responsible for identifying any or all such patent rights.

ISO 14490-8 was prepared by Technical Committee ISO/TC 172, *Optics and photonics*, Subcommittee SC 4, *Telescopic systems*.

ISO 14490 consists of the following parts, under the general title *Optics and optical instruments — Test methods for telescopic systems*:

- *Part 1: Test methods for basic characteristics*
- *Part 2: Test methods for binocular systems*
- *Part 3: Test methods for telescopic sights*
- *Part 4: Test methods for astronomical telescopes*
- *Part 5: Test methods for transmittance*
- *Part 6: Test methods for veiling glare index*
- *Part 7: Test methods for limit of resolution*
- *Part 8: Test methods for night-vision devices*